

RF Test Report

For

Applicant name: Shenzhen KingAnDa Technology Development Co., Ltd.

Address: East Block NO. 2, Shangxue Industrial Zone, Bantian Street,

Longgang District, Shenzhen, China

EUT name: Bluetooth headset

Brand name: YYK

Model number: YYK-Q17

Series model number: N/A

Issued By

Company name: BTF Testing Lab (Shenzhen) Co., Ltd.

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park,

Address: Tantou Community, Songgang Street, Bao'an District, Shenzhen,

China

Report number: BTF250422R00201

Test standards: FCC CFR Title 47 Part 15 Subpart C (§15.247)

FCC ID: 2AOZMYYK-Q17

Test conclusion: Pass

Date of sample

receipt: 2025-04-22

Test date: 2025-04-23 to 2025-04-28

Date of issue: 2025-04-28

Test by: Sean. He

Sean.He / Tester

Prepared by: Chris Liu

Chris Liu / Project

engineer

Approved * Olic Huang/EMC manager

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		Revisions content
R_V0	2025-04-28	Original
R_V0	2025-04-28	Original



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1 Introduction

1.1 Laboratory Location

Test location:	BTF Testing Lab (Shenzhen) Co., Ltd.	
Address: F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China		
Phone number:	+86-0755-23146130	
Fax number:	+86-0755-23146130	

1.2 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC - Designation No.: CN1409

BTF Testing Lab (Shenzhen) Co., Ltd. has been accredited as a testing laboratory by FCC (Federal Communications Commission). The test firm Registration No. is 518915.

• CNAS - Registration No.: CNAS L17568

BTF Testing Lab (Shenzhen) Co., Ltd. is accredited to ISO/IEC 17025:2017 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L17568.

A2LA - Registration No.: 6660.01

BTF Testing Lab (Shenzhen) Co., Ltd. is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 General requirements for the competence of testing and calibration laboratories.

1.3 Announcement

- (1) The test report reference to the report template version v0.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
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- (6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.





2 Product Information

2.1 Application Information

Company name:	Shenzhen KingAnDa Technology Development Co., Ltd.	
Address:	East Block NO. 2, Shangxue Industrial Zone, Bantian Street, Longgang District, Shenzhen, China	

2.2 Manufacturer Information

Company name:	Company name: Shenzhen KingAnDa Technology Development Co., Ltd.	
Address:	East Block NO. 2, Shangxue Industrial Zone, Bantian Street,	
	Longgang District, Shenzhen, China	

2.3 Factory Information

Company name: Shenzhen KingAnDa Technology Development Co., Ltd.	
Address:	East Block NO. 2, Shangxue Industrial Zone, Bantian Street,
	Longgang District, Shenzhen, China

2.4 General Description of Equipment under Test (EUT)

EUT name	Bluetooth headset
Under test model name	YYK-Q17
Series model name	N/A
Description of model name differentiation	N/A
Hardware Version	V2.0
Software Version	V1.0
Power supply:	Battery DC3.7V
AC adapter:	N/A

2.5 Technical Information

Operation frequency:	2402MHz ~ 2480MHz
Channel numbers:	79
Channel separation:	1MHz
Modulation technology:	GFSK, π/4 DQPSK, 8DPSK
Data rate:	1/2/3 Mbits/s
Max. E.I.R.P Power:	L: 1.94 dBm (8DPSK) R:4.30 dBm (8DPSK)
Antenna type:	Internal Antenna
Antenna gain:	2.67 dBi (declare by Applicant)
Antenna transmit mode:	SISO (1TX, 1RX)

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3 Test Information

3.1 Test Standards

Identity	Document Title
FCC CFR Title 47 Part 15 Subpart C (§15.247)	Intentional Radiators - Operation within the bands 902–928 MHz, 2400–2483.5 MHz, and 5725–5850 MHz.
ANSI C63.10-2020	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices
KDB 558074 D01 15.247 Meas Guidance v05r02	Guidance for Compliance Measurements on Digital Transmission System, Frequency Hopping Spread Spectrum System, and Hybrid System Devices Operating Under Section 15.247 of The FCC Rules

3.2 Summary of Test

Clauses	Test Items	Result
§ 15.203 § 15.247(b)(4)	Antenna Requirement	Pass
§ 15.207	AC Power Line Conducted Emission	Pass
§ 15.247(b)(1)	Conducted Output Power	Pass
§ 15.247(a)(1)	20dB Occupied Bandwidth	Pass
§ 15.247(a)(1)	Carrier Frequencies Separation	Pass
§ 15.247(a)(1)(iii)	Hopping Channel Number	Pass
§ 15.247(a)(1)(iii)	Dwell Time	Pass
§ 15.247(d)	Band-edge Emission Conduction Spurious Emission	Pass
§ 15.205 § 15.247(d)	Emissions in Restricted Frequency Bands	Pass
§ 15.209 § 15.247(d)	Emissions in Non-restricted Frequency Bands	Pass

Remark:

^{1.} Pass: met the requirements.

^{2.} N/A: not applicable.





3.3 Uncertainty of Test

Measurement	Value
Conducted Emission for LISN (9kHz ~ 150kHz)	±2.97 dB
Conducted Emission for LISN (150kHz ~ 30MHz)	±2.45 dB
Radiated Emission (30MHz ~ 1000MHz)	±4.80 dB
Radiated Emission (1GHz ~ 18GHz)	±4.82 dB
Radiated Emission (18GHz ~ 40GHz)	±4.94 dB
Occupied Channel Bandwidth	±5%
RF output power, conducted	±1.5 dB

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.4 Additions to, deviations, or exclusions from the method

None

3.5 Test Auxiliary Equipment

No.	Description	Manufacturer	Model	Serial Number	Certification
1	Power Adapter	HUAWEI	HW-110600C02	JH72L5N5910164	N/A

3.6 Test Equipment List

Radiated Emission Test							
Test Equipment	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due		
EMI Receiver	Rohde & Schwarz	ESCI7	101032	2024/10/25	2025/10/24		
Signal Analyzer	Rohde & Schwarz	FSQ40	100010	2024/10/25	2025/10/24		
Log periodic antenna	Schwarzbeck	VULB 9168	01328	2024/10/28	2025/10/27		
Preamplifier (30MHz ~ 1GHz)	Schwarzbeck	BBV9744	00246	2024/09/24	2025/09/23		
Horn Antenna	Schwarzbeck	BBHA9120D	2597	2024/10/30	2025/10/29		
Preamplifier (1GHz ~ 18GHz)	Schwarzbeck	BBV9718D	00008	2024/09/24	2025/09/23		
Horn Antenna (15GHz ~ 40GHz)	SCHWARZBECK	BBHA9170	1157	2024/10/24	2025/10/23		
Test Software	Frad	EZ_EMC	Versi	on: FA-03A2 R	E+		

Conducted Emission Test							
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due		
EMI Receiver	Rohde & Schwarz	ESCI3	101422	2024/10/25	2025/10/24		
V-LISN	Schwarzbeck	NSLK 8127	01073	2024/10/25	2025/10/24		
Coaxial Switcher	Schwarzbeck	CX210	CX210	1	1		
Pulse Limiter	Schwarzbeck	VTSD 9561-F	00953	1	1		

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Version:









Conducted test method						
Description				0.1.0.4	0.1.5	
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	
Spectrum Analyzer	Keysight	N9020A	MY50410020	2024/10/25	2025/10/24	
ESG Vector Signal Generator	Agilent	E4438C	MY45094854	2024/10/25	2025/10/24	
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2024/10/25	2025/10/24	
Wideband Radio Communication Tester	Rohde&Schwarz	CMW500	161997	2024/10/25	2025/10/24	
Temperature Humidity Chamber	ZZCKONG	ZZ-K02A	20210928007	2024/10/25	2025/10/24	
DC Power Supply	Tongmen	etm-6050c	20211026123	2024/10/25	2025/10/24	
RF Control Unit	Techy	TR1029-1	1	2024/10/25	2025/10/24	
RF Sensor Unit	Techy	TR1029-2	1	2024/10/25	2025/10/24	
Test Software	TST Pass	1	Version: 2.0			



4 Test Configuration

4.1 Environment Condition

Selected Values During Tests					
Temperature Test Voltage Relative Humidity Ambient Pressure					
Normal: +15°C to +35°C	3.70 Vdc	20% to 75%	86 kPa to 106 kPa		

4.2 Test mode

Transmitting mode: Keep the EUT in continuously transmitting mode with modulation					
Hopping mode:	Keep the EUT in normal hopping mode				
Remark: Per-scan all kind of data rate, and report only reflects the test data of worst data rate mode.					

4.3 Test Channel of EUT

In section 15.31(m), regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

Lowest	channel	Middle	channel	Highest	channel
Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)
0	2402	39	2441	78	2480

Channel list:

2402MHz 2403MHz 	20 21 	2422MHz 2423MHz	40 41	2442MHz 2443MHz	60 61	2462MHz 2463MHz
			41	2443MHz	61	2463MHz
		• • •				
2412MHz	30	2432MHz	50	2452MHz	70	2472MHz
2413MHz	31	2433MHz	51	2453MHz	71	2473MHz
2420MHz	38	2440MHz	58	2460MHz	78	2480MHz
2421MHz	39	2441MHz	59	2461MHz		- 111111
	2413MHz 2420MHz 2421MHz	2413MHz 31 2420MHz 38 2421MHz 39	2413MHz 31 2433MHz 2420MHz 38 2440MHz 2421MHz 39 2441MHz	2413MHz 31 2433MHz 51 2420MHz 38 2440MHz 58 2421MHz 39 2441MHz 59	2413MHz 31 2433MHz 51 2453MHz	2413MHz 31 2433MHz 51 2453MHz 71

4.4 Test software

Test software:	FCC Assist 1.0.2.2	Version:	1.0.2.2
Power Class:	10		

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4.5 Test procedure

AC Power Line Conducted Emission

The EUT is connected to the power mains through a LISN which provides $50~\Omega/50~\mu H$ of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be remeasured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Radiated test method

For below 1GHz:

- 1. The EUT was placed on the tabletop of a rotating table 0.8 m the ground at a 3 m semi anechoic chamber. The measurement distance from the EUT to the receiving antenna is 3 m.
- 2. EUT works in each mode of operation that needs to be tested. The highest signal levels relative to the limit shall be determined by rotating the EUT from 0° to 360° and with varying the measurement antenna height between 1 m and 4 m in vertical and horizontal polarizations.
- 3. Open the test software to control the test antenna and test turntable. Perform the test, save the test results, and export the test data.

For above 1GHz:

- 1. The EUT was placed on the tabletop of a rotating table 1.5 m the ground at a 3 m semi anechoic chamber. The measurement distance from the EUT to the receiving antenna is 3 m.
- 2. EUT works in each mode of operation that needs to be tested. The highest signal levels relative to the limit shall be determined by rotating the EUT from 0° to 360° and with varying the measurement antenna height between 1 m and 4 m in vertical and horizontal polarizations.
- 3. Open the test software to control the test antenna and test turntable. Perform the test, save the test results, and export the test data.

Conducted test method

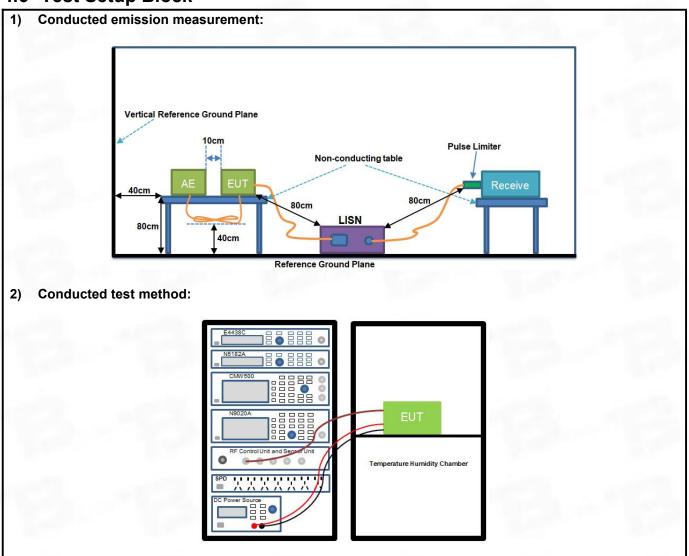
- 1. The Bluetooth antenna port of EUT was connected to the test port of the test system through an RF cable.
- 2. The EUT is keeping in continuous transmission mode and tested in all modulation modes.
- 3. Open the test software, prepare a test plan, and control the system through the software. After the test is completed, the test report is exported through the test software.

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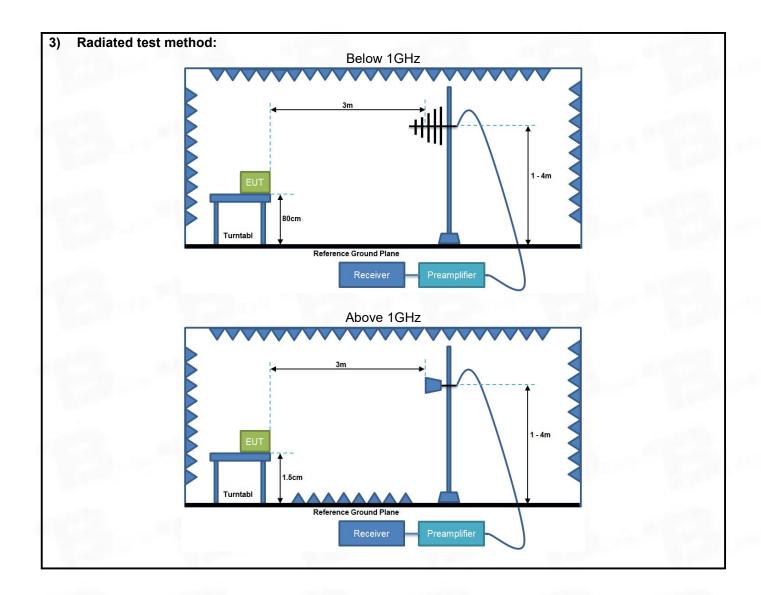
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4.6 Test Setup Block











5 Technical requirements specification

5.1 Summary of Test Result

Test Items	Limit	Test data	Verdict
Antenna Requirement	Please refer to §15.203 and §15.247(b)(4)	See Section 5.2	Pass
AC Power Line Conducted Emission	Please refer to §15.207	See Section 5.3	Pass
Conducted Output Power	Non-overlapping hopping channels: 1 watts (30dBm). All other frequency hopping systems: 0.125 watts (21dBm).	See Appendix-BT	Pass
20dB Occupied Bandwidth	Within authorization band	See Appendix-BT	Pass
Carrier Frequencies Separation	a) 0.025MHz or the 20dB bandwidth (whichever is greater).b) 0.025MHz or two-thirds of the 20dB bandwidth (whichever is greater).	See Appendix-BT	Pass
Hopping Channel Number	At least 15 channels.	See Appendix-BT	Pass
Dwell Time	Not be greater than 0.4 seconds.	See Appendix-BT	Pass
Band-edge Emission Conduction Spurious Emission	Please refer to §15.247(d)	See Appendix-BT	Pass
Emissions in Restricted Frequency Bands	Please refer to §15.205	See section 5.4	Pass
Emissions in Non-restricted Frequency Bands	Please refer to §15.209 and §15.247(d)	See section 5.5	Pass



5.2 Antenna Requirement

§15.203 requirement:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

§15.247(b) (4) requirement:

(4) The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

E.U.T Antenna:

The Bluetooth antenna is an Internal antenna which permanently attached, and the best case gain of the antenna is 2.67 dBi. See product internal photos for details.



5.3 AC Power Line Conducted Emission

	Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator					
	that is designed to be connected to the public utility (AC) power line, the					
Test Requirement:		hat is conducted back onto				
rest itequirement.	on any frequency or frequ	uencies, within the band 15	50 kHz to 30 MHz,			
	shall not exceed the limits in the following table, as measured using a 50					
	μH/50 ohms line impedance stabilization network (LISN).					
To at Mathead	Refer to ANSI C63.10-2020 section 6.2, standard test method for ac power-line					
Test Method:	conducted emissions from unlicensed wireless devices					
	Frequency of emission (MHz)	Conducted limit (dBµV)				
		Quasi-peak	Average			
Toot Limit	0.15-0.5	66 to 56*	56 to 46*			
Test Limit:	0.5-5	56	46			
	5-30	60	50			
	*Decreases with the logarithm of th	ne frequency.				

Temperature	22.5℃	Humidity	56%
Test voltage	AC 120V/60Hz	Test Engineer	Zero Zeng

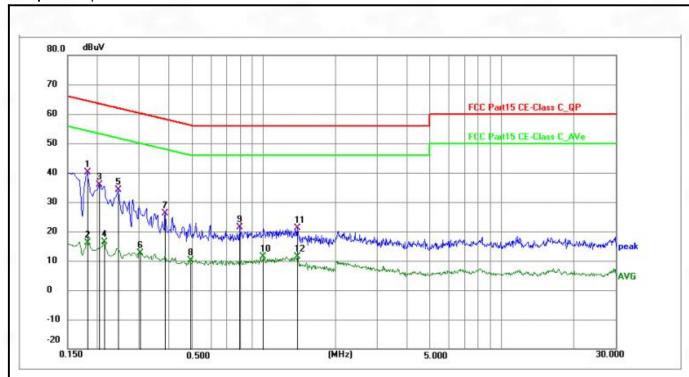
5.3.1 Test Setup

See section 4.5 for test setup description. The photo of test setup please refer to Appendix I Test Setup Photos

Remark: During the test, pre-scan GFSK, π /4-DQPSK, 8DPSK modulation mode, found 8DPSK modulation was worse case mode. The report only reflects the test data of worst mode.



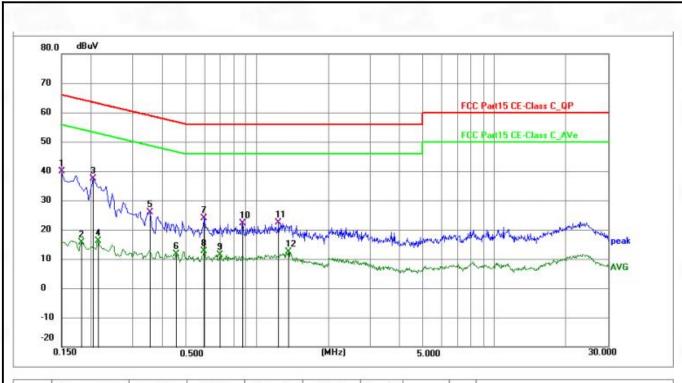
Test phase: L phase



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1 *	0.1814	29.48	10.62	40.10	64.42	-24.32	QP	Р	
2	0.1814	5.40	10.62	16.02	54.42	-38.40	AVG	Р	
3	0.2040	25.25	10.66	35.91	63.45	-27.54	QP	Р	
4	0.2130	5.73	10.66	16.39	53.09	-36.70	AVG	Р	
5	0.2444	23.56	10.66	34.22	61.95	-27.73	QP	Р	
6	0.3030	1.98	10.67	12.65	50.16	-37.51	AVG	Р	
7	0.3840	15.54	10.67	26.21	58.19	-31.98	QP	Р	
8	0.4920	-0.54	10.67	10.13	46.13	-36.00	AVG	Р	
9	0.7934	10.78	10.68	21.46	56.00	-34.54	QP	Р	
10	0.9960	0.41	10.86	11.27	46.00	-34.73	AVG	Р	
11	1.3874	10.41	10.78	21.19	56.00	-34.81	QP	Р	
12	1.3874	0.62	10.78	11.40	46.00	-34.60	AVG	Р	



Test phase: N phase



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1	0.1500	29.28	10.55	39.83	66.00	-26.17	QP	Р	
2	0.1814	5.11	10.56	15.67	54.42	-38.75	AVG	Р	
3 *	0.2040	26.78	10.56	37.34	63.45	-26.11	QP	Р	
4	0.2130	5.45	10.57	16.02	53.09	-37.07	AVG	Р	
5	0.3524	15.09	10.67	25.76	58.91	-33.15	QP	Р	
6	0.4560	0.86	10.74	11.60	46.77	-35.17	AVG	Р	
7	0.5955	12.95	10.83	23.78	56.00	-32.22	QP	Р	
8	0.5955	1.71	10.83	12.54	46.00	-33.46	AVG	Р	
9	0.6990	0.59	10.88	11.47	46.00	-34.53	AVG	Р	
10	0.8700	11.14	10.88	22.02	56.00	-33.98	QP	Р	
11	1.2344	11.59	10.88	22.47	56.00	-33.53	QP	Р	
12	1.3560	1.47	10.90	12.37	46.00	-33.63	AVG	Р	

Note1: Level= Read Level+ Cable Loss+ LISN Factor Note2: Margin=Level-Limit=Reading+factor-Limit





5.4 Emissions in Restricted Frequency Bands

Test Requirement:	In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`							
Test Method:	Radiated emissions tests	Radiated emissions tests						
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement dista nce (met ers)					
	0.009-0.490	2400/F(kHz)	300					
	0.490-1.705	24000/F(kHz)	30					
	1.705-30.0	30	30					
Test Limit:	30-88	100 **	3					
165t LIIIIIt.	88-216	150 **	3					
	216-960	200 **	3					
	Above 960	500	3					
	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241.							
Procedure:	ANSI C63.10-2020 secti	on 6 10 5 2						

Temperature	22.5℃	Humidity	56%
Test voltage	DC 3.7V From battery	Test Engineer	Zero Zeng

5.4.1 Test Setup

See section 4.5 for test setup description. The photo of test setup please refer to Appendix I Test Setup Photos

Remark: During the test, pre-scan GFSK, $\pi/4$ -DQPSK, 8DPSK modulation mode, found 8DPSK modulation was worse case mode. The report only reflects the test data of worst mode.

Test Mode: 8DPSK Test Channel: Lowest channel, Test Polarization: Vertical							
Frequency (MHz)	Reading (dBµV)	Factor (dB)	Level (dBµV/m)	Limit (dBµV/m)	Marging (dB)	Detector	Result
2310.00	52.39	3.85	56.24	74.00	-17.76	Peak	Pass
2310.00	42.29	3.85	46.14	54.00	-7.86	AVG	Pass
2390.00	52.57	3.91	56.48	74.00	-17.52	Peak	Pass
2390.00	41.80	3.91	45.72	54.00	-8.28	AVG	Pass
	Test Channel: Lowest channel, Test Polarization: Horizontal						
Frequency (MHz)	Reading (dBµV)	Factor (dB)	Level (dBµV/m)	Limit (dBµV/m)	Marging (dB)	Detector	Result

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2310.00	51.99	3.85	55.84	74.00	-18.16	Peak	Pass
2310.00	42.18	3.85	46.03	54.00	-7.97	AVG	Pass
2390.00	51.83	3.91	55.74	74.00	-18.26	Peak	Pass
2390.00	41.35	3.91	45.26	54.00	-8.74	AVG	Pass

Test Channel: Highest channel, Test Polarization: Vertical

Frequency (MHz)	Reading (dBµV)	Factor (dB)	Level (dBµV/m)	Limit (dBµV/m)	Marging (dB)	Detector	Result
2483.50	52.49	3.99	56.48	74.00	-17.52	Peak	Pass
2483.50	42.75	3.99	46.74	54.00	-7.26	AVG	Pass
2500.00	51.80	4.00	55.80	74.00	-18.20	Peak	Pass
2500.00	41.90	4.00	45.90	54.00	-8.10	AVG	Pass

Test Channel: Highest channel, Test Polarization: Horizontal

Frequency (MHz)	Reading (dBµV)	Factor (dB)	Level (dBµV/m)	Limit (dBµV/m)	Marging (dB)	Detector	Result
2483.50	51.67	3.99	55.66	74.00	-18.34	Peak	Pass
2483.50	41.30	3.99	45.29	54.00	-8.71	AVG	Pass
2500.00	51.45	4.00	55.45	74.00	-18.55	Peak	Pass
2500.00	41.16	4.00	45.16	54.00	-8.84	AVG	Pass

Note1:Level=Read Level + Antenna Factor + Cable Loss - Preamp Factor

Note2:Margin=Level-Limit=Reading+factor-Limit





5.5 Emissions in Non-restricted Frequency Bands

Test Requirement:	15.205(a), mus	In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`				
Test Method:	Radiated emissions tests					
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement dista nce (met ers)			
	0.009-0.490	2400/F(kHz)	300			
	0.490-1.705	24000/F(kHz)	30			
	1.705-30.0	30	30			
Test Limit:	30-88	100 **	3			
Test Lillill.	88-216	150 **	3			
	216-960	200 **	3			
	Above 960	500	3			
	radiators opera bands 54-72 N	paragraph (g), fundamental emissio ating under this section shall not be I IHz, 76-88 MHz, 174-216 MHz or 47 n these frequency bands is permitte	ocated in the frequency '0-806 MHz. However,			
Procedure:	ANSI C63.10-2020 secti	on 6.6.4				

Test Requirement:		15.205(a), must also comply with the radiated emission limits specified in 15.209(a)(see § 15.205(c)).						
Test Method:	Radiated emissions test	Radiated emissions tests						
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement dista nce (met ers)					
	0.009-0.490	2400/F(kHz)	300					
	0.490-1.705	24000/F(kHz)	30					
	1.705-30.0	30	30					
Test Limit:	30-88	100 **	3					
rest Limit.	88-216	150 **	3					
	216-960	200 **	3					
	Above 960	500	3					
	radiators opera bands 54-72 M	paragraph (g), fundamental emissio ating under this section shall not be I IHz, 76-88 MHz, 174-216 MHz or 47 n these frequency bands is permitte	ocated in the frequency '0-806 MHz. However,					
Procedure:	ANSI C63.10-2020 secti	on 6.6.4						

Temperature	22.5℃	Humidity	56%
Test voltage	DC 3.7V From battery	Test Engineer	Zero Zeng

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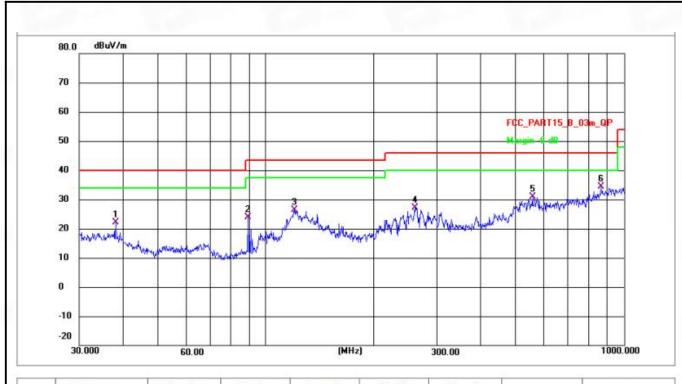
5.5.1 Test Setup

See section 4.5 for test setup description. The photo of test setup please refer to Appendix I Test Setup Photos

Remark: During the test, pre-scan GFSK, $\pi/4$ -DQPSK, 8DPSK modulation mode, found 8DPSK modulation was worse case mode. The report only reflects the test data of worst mode.

For below 1GHz:

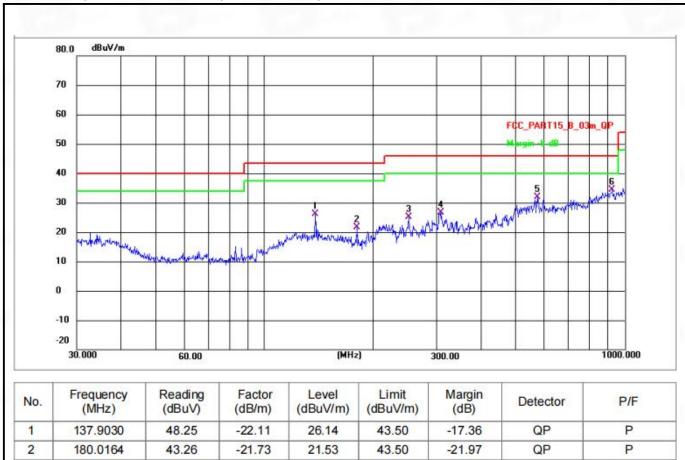
Test antenna polarization: Vertical (30 MHz to 1 GHz)



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	37.9450	31.75	-9.65	22.10	40.00	-17.90	QP	Р
2	89.1200	46.49	-22.64	23.85	43.50	-19.65	QP	Р
3	120.0660	48.60	-22.29	26.31	43.50	-17.19	QP	P
4	261.0582	48.02	-20.96	27.06	46.00	-18.94	QP	Р
5	555.7990	49.41	-18.63	30.78	46.00	-15.22	QP	Р
6 *	866.0880	51.08	-16.78	34.30	46.00	-11.70	QP	Р



Test antenna polarization: Horizontal (30 MHz to 1 GHz)



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	137.9030	48.25	-22.11	26.14	43.50	-17.36	QP	Р
2	180.0164	43.26	-21.73	21.53	43.50	-21.97	QP	Р
3	252.0627	46.08	-21.04	25.04	46.00	-20.96	QP	Р
4	308.9125	47.09	-20.55	26.54	46.00	-19.46	QP	Р
5	572.6144	50.31	-18.52	31.79	46.00	-14.21	QP	Р
6 *	922.5157	50.45	-16.08	34.37	46.00	-11.63	QP	Р

Note1:Level=Read Level + Antenna Factor + Cable Loss - Preamp Factor Note2:Margin=Level-Limit=Reading+factor-Limit



For above 1GHz:

				e: 8DPSK			
Frequency	Reading	Factor	Level	el, Test Polari Limit	Marging	aı	
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector	Result
4804.00	76.09	-48.89	27.20	74.00	-46.80	Peak	Pass
4804.00	65.55	-48.89	16.67	54.00	-37.33	AVG	Pass
	Tes	st Channel: L	owest channe	I. Test Polariz	ation: Horizoi	ntal	
Frequency	Reading	Factor	Level	Limit	Marging		
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector	Result
4804.00	76.64	-48.89	27.75	74.00	-46.25	Peak	Pass
4804.00	66.25	-48.89	17.36	54.00	-36.64	AVG	Pass
	т	est Channel	Middle channe	el Test Polari	zation: Vertic	al	
Frequency	Reading	Factor	Level	Limit	Marging		
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector	Result
4882.00	77.46	-48.84	28.62	74.00	-45.38	Peak	Pass
4882.00	66.77	-48.84	17.94	54.00	-36.06	AVG	Pass
	Te	st Channel: N	liddle channel	. Test Polariza	ation: Horizor	ntal	
Frequency	Reading	Factor	Level	Limit	Marging		D!
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector	Result
4882.00	78.69	-48.84	29.86	74.00	-44.14	Peak	Pass
4882.00	69.11	-48.84	20.27	54.00	-33.73	AVG	Pass
	Te	est Channel: I	lighest chann	el, Test Polar	ization: Vertic	al	
Frequency	Reading	Factor	Level	Limit	Marging	Detector	Dogult
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector	Result
4960.00	76.82	-48.79	28.04	74.00	-45.96	Peak	Pass
4960.00	67.23	-48.79	18.45	54.00	-35.55	AVG	Pass
	Tes	st Channel: H	ighest channe	I, Test Polariz	ation: Horizo	ntal	
Frequency (MHz)	Reading (dBµV)	Factor (dB)	Level (dBµV/m)	Limit (dBµV/m)	Marging (dB)	Detector	Result
4960.00	78.45	-48.79	29.66	74.00	-44.34	Peak	Pass
4960.00	68.33	-48.79	19.55	54.00	-34.45	AVG	Pass

Note1:Level=Read Level + Antenna Factor + Cable Loss - Preamp Factor Note2:Margin=Level-Limit=Reading+factor-Limit





5.6 Occupied Bandwidth

3.0 Occupied ba	
Test Requirement:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in § § 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Method:	Occupied bandwidth—relative measurement procedure
Test Limit:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in § § 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Procedure:	a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement. c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2. d) Steps a) through c) might require iteration to adjust within the specified tolerances. e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target "-xx dB down" requirement; that is, if the requirement calls for measuring the -20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the reference value. f) Set detection mode to peak and trace mode to max hold. g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference value). h) Determine the "-xx dB down amplitude" using [(reference value) - xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument. i) If the reference value is determined by an unmodulated carrier, then turn the EUT modulation ON, and either clear the existing trace or start a new trace on the spectrum analyzer and allow the new trace to stabilize. Otherwise, the trace from step g) shall be used for step j). j) Place two markers, one at the lowest frequency and the other at the highest frequency of the envelope of the spectral display, such that each marker is at or slightly below the "-xx dB do

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Version Version: 1/00





instrument display; the plot axes and the scale units per division shall be clearly
labeled. Tabular data may be reported in addition to the plot(s).

5.6.1 E.U.T. Operation:

Operating Environment:				
Temperature:	22.3 °C			
Humidity:	45.2 %			
Atmospheric Pressure:	1010 hpa			
Test Voltage	DC 3.7V From battery			

5.6.2 Test Setup

See section 4.5 for test setup description. The photo of test setup please refer to Appendix I Test Setup Photos

5.6.3 Test Data:

Please Refer to Appendix-BT for Details.



5.7 Maximum Conducted Output Power

Test Requirement:	For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Test Method:	Output power test procedure for frequency-hopping spread-spectrum (FHSS) devices
Test Limit:	For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Procedure:	This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. The hopping shall be disabled for this test: a) Use the following spectrum analyzer settings: 1) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. 2) RBW > 20 dB bandwidth of the emission being measured. 3) VBW >= RBW. 4) Sweep: Auto. 5) Detector function: Peak. 6) Trace: Max hold. b) Allow trace to stabilize. c) Use the marker-to-peak function to set the marker to the peak of the emission. d) The indicated level is the peak output power, after any corrections for external attenuators and cables. e) A plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer.

5.7.1 E.U.T. Operation:

Operating Environment:		
Temperature:	22.3 °C	
Humidity:	45.2 %	
Atmospheric Pressure:	1010 hpa	
Test Voltage	DC 3.7V From battery	

5.7.2 Test Setup

See section 4.5 for test setup description. The photo of test setup please refer to Appendix I Test Setup Photos

5.7.3 Test Data:

Please Refer to Appendix-BT for Details.

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5.8 Channel Separation

Test Requirement:	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Method:	Carrier frequency separation
Test Limit:	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A plot of the data shall be included in the test report.

5.8.1 E.U.T. Operation:

Operating Environment:			
Temperature:	22.3 °C		
Humidity:	45.2 %		
Atmospheric Pressure:	1010 hpa		
Test Voltage	DC 3.7V From battery		

5.8.2 Test Setup

See section 4.5 for test setup description. The photo of test setup please refer to Appendix I Test Setup Photos

5.8.3 Test Data:

Please Refer to Appendix-BT for Details.



5.9 Number of Hopping Frequencies

	opping i requesione
Test Requirement:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	Number of hopping frequencies
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data shall be included in the test report.

5.9.1 E.U.T. Operation:

Operating Environment:			
Temperature:	22.3 °C		
Humidity:	45.2 %		
Atmospheric Pressure:	1010 hpa		
Test Voltage	DC 3.7V From battery		

5.9.2 Test Setup

See section 4.5 for test setup description. The photo of test setup please refer to Appendix I Test Setup Photos

5.9.3 Test Data:

Please Refer to Appendix-BT for Details.





5.10 Dwell Time

Test Requirement:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	Time of occupancy (dwell time)
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements. Determine the number of hops over the sweep time and calculate the total number of hops in the period specified in the requirements, using the following equation: (Number of hops in the period specified in the requirements) = (number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hops in the period specified in the requirements. If the number of hops in a specific time varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation. The measured transmit time and time between hops shall be consistent with the values described in the operational description for the EUT.

5.10.1 E.U.T. Operation:

Operating Environment:	
Temperature:	22.3 °C
Humidity:	45.2 %
Atmospheric Pressure:	1010 hpa

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Report Number: BTF250422R00201

Test Voltage

DC 3.7V From battery

5.10.2 Test Setup

See section 4.5 for test setup description. The photo of test setup please refer to Appendix I Test Setup **Photos**

5.10.3 Test Data:

Please Refer to Appendix-BT for Details.



5.11 Emissions in non-restricted frequency bands

Test Requirement:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Method:	Conducted spurious emissions test methodology
Test Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Procedure:	Conducted spurious emissions shall be measured for the transmit frequency, per 5.5 and 5.6, and at the maximum transmit powers. Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The instrument shall span 30 MHz to 10 times the operating frequency in GHz, with a resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector. The band 30 MHz to the highest frequency may be split into smaller spans, as long as the entire spectrum is covered.

5.11.1 E.U.T. Operation:

Operating Environment:	
Temperature:	22.3 °C
Humidity:	45.2 %
Atmospheric Pressure:	1010 hpa
Test Voltage	DC 3.7V From battery

5.11.2 Test Setup

See section 4.5 for test setup description. The photo of test setup please refer to Appendix I Test Setup Photos

5.11.3 Test Data:

Please Refer to Appendix-BT for Details.





6 Test Setup Photos

Please refer to Appendix I Test Setup Photos.

7 EUT Constructional Details (EUT Photos)

Please refer to Appendix II External Photos and Appendix III Internal Photos.







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--END OF REPORT--